











#### LMV341-N, LMV342-N, LMV344-N

SNOS990H - APRIL 2002-REVISED JUNE 2016

# LMV34x-N Single Rail-to-Rail Output CMOS Operation Amplifier With Shutdown

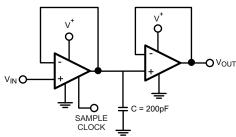
#### **Features**

- Typical 2.7 V Supply Values (Unless Otherwise
- Ensured 2.7 V and 5 V Specifications
- Input Referred Voltage Noise at 10 kHz: 29 nV/√Hz
- Supply Current (Per Amplifier): 100 µA
- Gain Bandwidth Product: 1 MHz
- Slew Rate: 1 V/us
- Shutdown Current (LMV341-N): 45 pA
- Turnon Time From Shutdown (LMV341-N): 5 µs
- Input Bias Current: 20 fA

## **Applications**

- Cordless or Cellular Phones
- Laptops
- **PDAs**
- PCMCIA or Audio
- Portable or Battery-Powered Electronic Equipment
- Supply Current Monitoring
- **Battery Monitoring**
- **Buffers**
- **Filters**
- Drivers

#### Sample and Hold Circuit



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## 3 Description

The LMV34x-N devices are single, dual, and quad low-voltage, low-power operational amplifiers. They are designed specifically for low-voltage portable applications. Other important product characteristics are low input bias current, rail-to-rail output, and wide temperature range.

The patented class AB turnaround stage significantly reduces the noise at higher frequencies, power consumption, and offset voltage. The PMOS input stage provides the user with ultra-low input bias current of 20 fA (typical) and high input impedance.

The industrial-plus temperature range of -40°C to 125°C allows the LMV34x-N to accommodate a broad range of extended environment applications. LMV341-N expands Texas Instrument's Silicon Dust amplifier portfolio offering enhancements in size, speed, and power savings. The LMV34x-N devices are specified to operate over the voltage range of 2.7 V to 5.5 V and all have rail-to-rail output.

The LMV341-N offers a shutdown pin that can be used to disable the device. Once in shutdown mode. the supply current is reduced to 45 pA (typical). The LMV34x-N devices have 29-nV voltage noise at 10 KHz, 1 MHz GBW, 1-V/µs slew rate, 0.25 mVos, and 0.1-µA shutdown current (LMV341-N).

The LMV341-N is offered in the tiny 6-pin SC70 package, the LMV342-N in space-saving 8-pin VSSOP and SOIC packages, and the LMV344-N in 14-pin TSSOP and SOIC packages. These small package amplifiers offer an ideal solution for applications requiring minimum PCB footprint. Applications with area constrained PCB requirements include portable electronics such as cellular handsets and PDAs.

### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)	
LMV341-N	SC70 (6)	2.00 mm × 1.25 mm	
1.8.0 (0.40.8)	VSSOP (8)	3.00 mm × 3.00 mm	
LMV342-N	SOIC (8)	4.90 mm × 3.91 mm	
L MAN / O 4 4 N I	TSSOP (14)	5.00 mm × 4.40 mm	
LMV344-N	SOIC (14)	8.64 mm × 3.91 mm	

(1) For all available packages, see the orderable addendum at the end of the data sheet.



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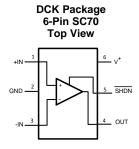
## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	hanges from Revision G (March 2013) to Revision H	Page
•	Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	
_		
CI	hanges from Revision F (March 2012) to Revision G	Page
•	Changed layout of National Data Sheet to TI format	1



## 5 Pin Configuration and Functions

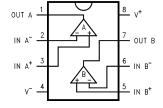


#### Pin Functions - LMV341-N

PIN		TYPE <sup>(1)</sup>	DESCRIPTION			
NAME	NO.	ITPE\/	DESCRIPTION			
+IN	1	I	Noninverting input			
-IN	3	1	Inverting input			
GND	2	Р	Negative supply input			
OUT	4	0	Output			
V <sup>+</sup>	6	Р	Positive supply input			
SHDN	5	I	Active low enable input			

(1) I = Input, O = Output, and P = Power

#### DGK or D Package 8-Pin VSSOP or SOIC Top View



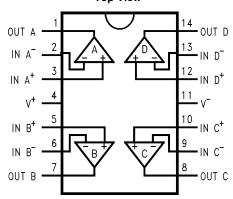
#### Pin Functions - LMV342-N

PIN		TYPE <sup>(1)</sup>	DESCRIPTION		
NAME	NO.	ITPE	DESCRIPTION		
IN A <sup>+</sup>	3	I	Noninverting input, channel A		
IN A <sup>-</sup>	2	1	Inverting input, channel A		
IN B <sup>+</sup>	5	I	Noninverting input, channel B		
IN B <sup>-</sup>	6	I	Inverting input, channel B		
OUT A	1	0	Output, channel A		
OUT B	7	0	Output, channel B		
V <sup>+</sup>	8	Р	Positive (highest) power supply		
V <sup>-</sup>	4	Р	Negative (lowest) power supply		

(1) I = Input, O = Output, and P = Power



#### PW or D Package 14-Pin TSSOP or SOIC Top View



## Pin Functions - LMV344-N

THI GIOGOID ENVOTTIN						
N	TVDE(1)	DESCRIPTION				
NO.	TIPE	DESCRIPTION				
3	I	Noninverting input, channel A				
2	I	Inverting input, channel A				
5	I	oninverting input, channel B				
6	I	Inverting input, channel B				
10	I	Ioninverting input, channel C				
9	1	Inverting input, channel C				
12	I	Noninverting input, channel D				
13	I	Inverting input, channel D				
1	0	Output, channel A				
7	0	Output, channel B				
8	0	Output, channel C				
14	0	Output, channel D				
4	Р	Positive (highest) power supply				
11	Р	legative (lowest) power supply				
	NO.  3 2 5 6 10 9 12 13 1 7 8 14 4	NO.  3				

(1) I = Input, O = Output, and P = Power



## **Specifications**

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)(2)

		MIN	MAX	UNIT
Differential input voltage		±Supply	voltage	
Supply voltage (V <sup>+</sup> – V <sup>-</sup> )			6	V
Output short circuit to V +	Sec	e <sup>(3)</sup>		
Output short circuit to V -	ut short circuit to V -			
Land to constitute	Infrared or convection reflow (20 s)		235	00
Lead temperature	Wave soldering (10 s)		260	°C
Junction temperature, T <sub>J</sub> <sup>(5)</sup>			150	°C
Storage temperature, T <sub>stg</sub>	-65	150	°C	

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 6.2 ESD Ratings

			VALUE	UNIT
V	Clastrostatia diasharas	Human-body model (HBM) <sup>(1)</sup>	±2000	V
V <sub>(ESD)</sub>	Electrostatic discharge	Machine model (MM) <sup>(2)</sup>	±200	V

Human Body Model, applicable std. MIL-STD-883, Method 3015.7.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
Supply voltage	2.7	5.5	V
Temperature	-40	125	°C

#### 6.4 Thermal Information

		LMV341-N	LMV:	342-N	N LMV344-N		
	THERMAL METRIC <sup>(1)</sup>	DCK (SC70)	D (SOIC)	DGK (VSSOP)	D (SOIC)	PW (TSSOP)	UNIT
		6 PINS	8 PINS	8 PINS	14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	414	190	235	145	155	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	116.1	65.2	68.4	45.9	50.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	53.3	61.4	98.8	44.1	66.2	°C/W
ΨЈТ	Junction-to-top characterization parameter	8.8	16.1	9.8	10.2	6.3	°C/W
ΨЈВ	Junction-to-board characterization parameter	52.7	60.8	97.3	43.7	65.6	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	_	_	_	_	_	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.

Shorting output to V<sup>+</sup> will adversely affect reliability.

Shorting output to V<sup>-</sup> will adversely affect reliability.

The maximum power dissipation is a function of  $T_{J(MAX)}$ ,  $R_{\theta JA}$ . The maximum allowable power dissipation at any ambient temperature is  $P_D = (T_{J(MAX)} - T_A) / R_{\theta JA}$ . All numbers apply for packages soldered directly onto a PCB.

Machine Model, applicable std. JESD22-A115-A (ESD MM std. of JEDEC) Field-Induced Charge-Device Model, applicable std. JESD22-C101-C (ESD FICDM std. of JEDEC).



## 6.5 Electrical Characteristics - 2.7 V (DC)

 $T_{\perp} = 25^{\circ}C$ ,  $V^{+} = 2.7 \text{ V}$ ,  $V^{-} = 0 \text{ V}$ ,  $V_{CM} = V^{+}/2$ ,  $V_{O} = V^{+}/2$ , and  $R_{\perp} > 1 \text{ M}\Omega$  (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST C	ONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
		L NAV/2 44 NI	T <sub>J</sub> = 25°C		0.25	4	
.,	land offert velters	LMV341-N	-40°C ≤ T <sub>J</sub> ≤ 125°C			4.5	mV
Vos	Input offset voltage	LMV342-N and	$T_J = 25^{\circ}C$		0.55	5	
		LMV344-N	-40°C ≤ T <sub>J</sub> ≤ 125°C			5.5	
TCV <sub>OS</sub>	Input offset voltage average drift				1.7		μV/°C
	lament bina accument	$T_J = 25^{\circ}C$			0.02	120	- 1
I <sub>B</sub>	Input bias current	-40°C ≤ T <sub>J</sub> ≤ 150°C				250	pА
los	Input offset current				6.6		fA
		Dan a san l'Can	$T_J = 25$ °C		100	170	
		Per amplifier	-40°C ≤ T <sub>J</sub> ≤ 125°C			230	
l <sub>S</sub>	Supply current	Shutdown mode,	T <sub>J</sub> = 25°C		4.5 × 10 <sup>-5</sup>	1	μA
		$V_{SD} = 0 V$ , LMV341-N	-40°C ≤ T <sub>J</sub> ≤ 125°C			1.5	
01.100		$0 \text{ V} \le \text{V}_{\text{CM}} \le 1.7 \text{ V},$	$T_J = 25^{\circ}C$	56	80		
CMRR	Common-mode rejection ratio	$0 \text{ V} \leq \text{V}_{\text{CM}} \leq 1.6 \text{ V}$	-40°C ≤ T <sub>J</sub> ≤ 125°C	50		dB	
			T <sub>J</sub> = 25°C	65	82		dB
PSRR	Power supply rejection ratio	$2.7 \text{ V} \leq \text{V}^+ \leq 5 \text{ V}$	-40°C ≤ T <sub>J</sub> ≤ 125°C	60			
	Input common-mode voltage	For CMRR ≥ 50 dB	V+		1.9	1.7	V
$V_{CM}$			V-	0	-0.2		
		$R_L = 10 \text{ k}\Omega \text{ to } 1.35 \text{ V}$	T <sub>J</sub> = 25°C	78	113		dB
			-40°C ≤ T <sub>J</sub> ≤ 125°C	70			
A <sub>V</sub>	Large signal voltage gain		T <sub>J</sub> = 25°C	72	103		
		$R_L = 2 k\Omega$ to 1.35 V	-40°C ≤ T <sub>J</sub> ≤ 125°C	64			
			T <sub>J</sub> = 25°C		24	60	
		R <sub>L</sub> = 2 kΩ to 1.35 V	-40°C ≤ T <sub>J</sub> ≤ 125°C			95	
			$T_J = 25$ °C	60	26		
	Outract and a		95			.,	
Vo	Output swing		T <sub>J</sub> = 25°C		5	30	mV
		D 40104-4051/	-40°C ≤ T <sub>J</sub> ≤ 125°C			40	
		$R_L = 10 \text{ k}\Omega \text{ to } 1.35 \text{ V}$	$T_J = 25^{\circ}C$	30	5.3		
			-40°C ≤ T <sub>J</sub> ≤ 125°C	40			
		Sourcing, LMV341-N an	d LMV342-N	20	32		<u> </u>
lo	Output short-circuit current	Sourcing, LMV344-N	18	24		mA	
	,	Sinking	15	24			
· ·on	Turnon time from shutdown	LMV341-N		5		μs	
	01 11 1	ON mode, LMV341-N		2.4	1.7	2.7	V
$V_{SD}$	Shutdown pin voltage	Shutdown mode, LMV34	0	1	0.8		

<sup>(1)</sup> Electrical characteristic values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that  $T_J = T_A$ . No specification of parametric performance is indicated in the electrical tables under conditions of internal self heating where  $T_J > T_A$ . All limits are specified by testing or statistical analysis.

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Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and also depends on the application and configuration. The typical values are not tested and are not ensured on shipped production material.



#### 6.6 Electrical Characteristics – 2.7 V (AC)

 $T_J = 25^{\circ}\text{C}$ ,  $V^+ = 2.7\text{V}$ ,  $V^- = 0\text{V}$ ,  $V_{CM} = V^+/2$ ,  $V_O = V^+/2$ , and  $R_L > 1$  M $\Omega$  (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST CONDITIONS	MIN <sup>(2)</sup> TYP <sup>(3)</sup> MAX <sup>(2)</sup>	UNIT
SR	Slew rate	$R_L = 10 \text{ k}\Omega^{(4)}$	1	V/µs
GBW	Gain bandwidth product	$R_L = 100 \text{ k}\Omega, C_L = 200 \text{ pF}$	1	MHz
$\Phi_{m}$	Phase margin	$R_L = 100 \text{ k}\Omega$	72	0
G <sub>m</sub>	Gain margin	$R_L = 100 \text{ k}\Omega$	20	dB
e <sub>n</sub>	Input-referred voltage noise	f = 1 kHz	40	nV/√ <del>Hz</del>
in	Input-referred current noise	f = 1 kHz	0.001	pA/√Hz
THD	Total harmonic distortion	$f = 1 \text{ kHz}, A_V = +1,$ $R_L = 600 \Omega, V_{IN} = 1 V_{PP}$	0.017%	

- (1) Electrical characteristic values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T<sub>J</sub> = T<sub>A</sub>. No specification of parametric performance is indicated in the electrical tables under conditions of internal self heating where T<sub>J</sub> > T<sub>A</sub>.
- (2) All limits are specified by testing or statistical analysis.
- (3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and also depends on the application and configuration. The typical values are not tested and are not ensured on shipped production material.
- (4) Connected as voltage follower with 2-V<sub>PP</sub> step input. Number specified is the slower of the positive and negative slew rates.

#### 6.7 Electrical Characteristics – 5 V (DC)

 $T_J = 25^{\circ}C$ ,  $V^+ = 5 \text{ V}$ ,  $V^- = 0 \text{ V}$ ,  $V_{CM} = V^+/2$ ,  $V_O = V^+/2$ , and  $R_L > 1 \text{ M}\Omega$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CON	DITIONS	MIN <sup>(2)</sup>	TYP(3)	MAX <sup>(2)</sup>	UNIT	
	land offer the selfer se	LMV341-N	T <sub>J</sub> = 25°C		0.025	4		
\ <i>/</i>		LIVIV 34 I-IN	$-40$ °C $\leq T_{\rm J} \leq 125$ °C			4.5	m\/	
Vos	Input offset voltage	LMV342-N and LMV344-N	$T_J = 25^{\circ}C$		0.7	5	mV	
		LIVIV 342-IN AND LIVIV 344-IN	-40°C ≤ T <sub>J</sub> ≤ 125°C			5.5		
TCV <sub>OS</sub>	Input offset voltage average drift				1.9		μV/°C	
	Innut biog gurrent	T <sub>J</sub> = 25°C			0.02	200	<b>5</b> A	
I <sub>B</sub>	Input bias current	$-40$ °C $\leq T_J \leq 125$ °C			375	pА		
Ios	Input offset current				6.6		fA	
	Supply current	Per amplifier	$T_J = 25^{\circ}C$		107	200		
		rei ampillei	$-40$ °C $\leq T_J \leq 125$ °C			260		
I <sub>S</sub>		Shutdown mode,	T <sub>J</sub> = 25°C		0.033	1	μΑ	
		V <sub>SD</sub> = 0 V, LMV341-N	$-40$ °C $\leq$ T <sub>J</sub> $\leq$ 125°C			1.5		
CMRR	Common-mode rejection ratio	$0 \text{ V} \leq \text{V}_{CM} \leq 4 \text{ V},$	$T_J = 25^{\circ}C$	56	86		dB	
CIVILLE		0 V ≤ V <sub>CM</sub> ≤ 3.9 V	–40°C ≤ T <sub>J</sub> ≤ 125°C	50			uБ	
PSRR	Power supply rejection ratio	2.7 V ≤ V <sup>+</sup> ≤ 5 V	$T_J = 25^{\circ}C$	65	82		dB	
FORK	rower supply rejection ratio	2.7 V 3 V 3 3 V	$-40$ °C $\leq$ T <sub>J</sub> $\leq$ 125°C	60			uБ	
V	Input common-mode voltage	For CMRR ≥ 50 dB	V+		4.2	4	V	
$V_{CM}$	input common-mode voltage	TOI CIVIRR 2 30 db	V–	0	-0.2		V	
		$R_1 = 10 \text{ k}\Omega \text{ to } 2.5 \text{ V}$	$T_J = 25^{\circ}C$	78	116			
$A_V$	Large signal voltage gain (4)	N_ = 10 N22 10 2.3 V	–40°C ≤ T <sub>J</sub> ≤ 125°C	70			dB	
$\neg \lor$	Large signal voltage galli	$R_1 = 2 k\Omega$ to 2.5 V	$T_J = 25^{\circ}C$	72	107		uБ	
		N 2 N12 10 2.3 V	-40°C ≤ T <sub>J</sub> ≤ 125°C	64				

<sup>(1)</sup> Electrical characteristic values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T<sub>J</sub> = T<sub>A</sub>. No specification of parametric performance is indicated in the electrical tables under conditions of internal self heating where T<sub>J</sub> > T<sub>A</sub>.

<sup>(2)</sup> All limits are specified by testing or statistical analysis.

<sup>(3)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and also depends on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

<sup>4)</sup>  $R_L$  is connected to mid-supply. The output voltage is GND + 0.2 V  $\leq$  V<sub>O</sub>  $\leq$  V<sup>+</sup>- 0.2 V



## Electrical Characteristics - 5 V (DC) (continued)

 $T_J = 25^{\circ}C$ ,  $V^+ = 5 \text{ V}$ ,  $V^- = 0 \text{ V}$ ,  $V_{CM} = V^+/2$ ,  $V_O = V^+/2$ , and  $R_L > 1 \text{ M}\Omega$  (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST C	ONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT	
			T <sub>J</sub> = 25°C		32	60		
		D 2 k0 to 2 5 V	–40°C ≤ T <sub>J</sub> ≤ 125°C			95		
		$R_L = 2 k\Omega$ to 2.5 V	$T_J = 25^{\circ}C$	60	34			
.,	Outrot roller		-40°C ≤ T <sub>J</sub> ≤ 125°C	95				
Vo	Output swing	$R_L = 10 \text{ k}\Omega \text{ to } 2.5 \text{ V}$	T <sub>J</sub> = 25°C		7	30	mV	
			-40°C ≤ T <sub>J</sub> ≤ 125°C			40		
			T <sub>J</sub> = 25°C	30	7			
			-40°C ≤ T <sub>J</sub> ≤ 125°C	40				
	Output about aires it as most	Sourcing	85	113		mA		
I <sub>O</sub> Out	Output short-circuit current	Sinking	50	75				
t <sub>on</sub>	Turnon time from shutdown	LMV341-N		5		μs		
V	Chutdown nin voltogo	ON mode, LMV341-N	4.5	3.1	5	V		
$V_{SD}$	Shutdown pin voltage	Shutdown mode, LMV341-N	0	1	0.8			

## 6.8 Electrical Characteristics – 5 V (AC)

 $T_J = 25^{\circ}C$ ,  $V^+ = 5 \text{ V}$ ,  $V^- = 0 \text{ V}$ ,  $V_{CM} = V^+/2$ ,  $V_O = V^+/2$  and  $R_L > 1 \text{ M}\Omega$  (unless otherwise noted)<sup>(1)</sup>

-3 = -, · ·, · - · ·, · - · · · · · · ·									
	PARAMETER	CONDITIONS	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT			
SR	Slew rate	$R_L = 10 \text{ k}\Omega^{(4)}$		1		V/µs			
GBW	Gain-bandwidth product	$R_L = 10 \text{ k}\Omega, C_L = 200 \text{ pF}$		1		MHz			
$\Phi_{m}$	Phase margin	$R_L = 100 \text{ k}\Omega$		70		deg			
G <sub>m</sub>	Gain margin	$R_L = 100 \text{ k}\Omega$		20		dB			
e <sub>n</sub>	Input-referred voltage noise	f = 1 kHz		39		nV/√ <del>Hz</del>			
in	Input-referred current noise	f = 1 kHz		0.001		pA/√ <del>Hz</del>			
THD	Total harmonic distortion	$f = 1 \text{ kHz}, A_V = +1, \\ R_L = 600 \Omega, V_{IN} = 1V_{PP}$	0	.012%					

<sup>(1)</sup> Electrical characteristic values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T<sub>J</sub> = T<sub>A</sub>. No specification of parametric performance is indicated in the electrical tables under conditions of internal self heating where T<sub>J</sub> > T<sub>A</sub>.

(4) Connected as voltage follower with 2-V<sub>PP</sub> step input. Number specified is the slower of the positive and negative slew rates.

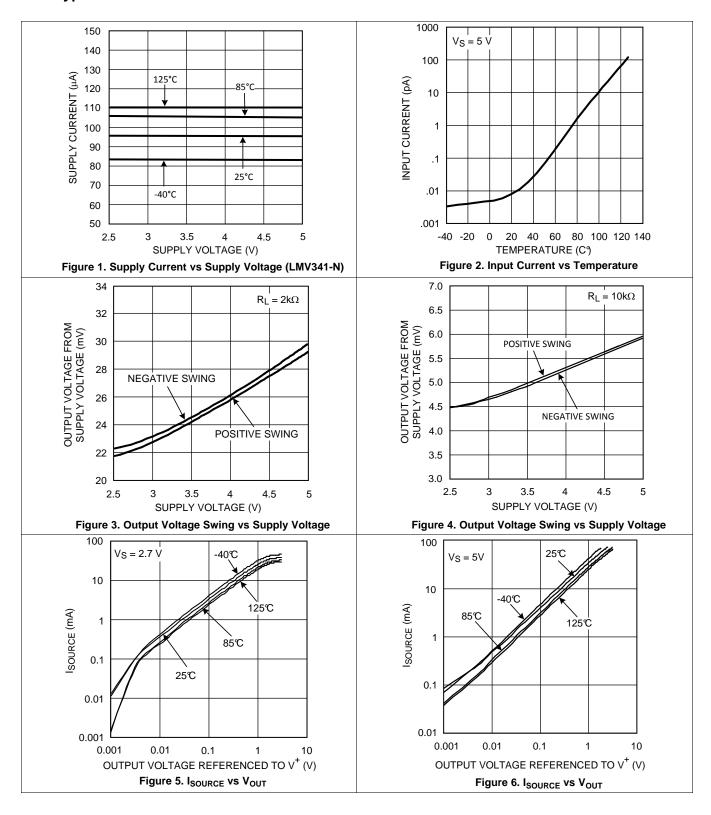
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<sup>(2)</sup> All limits are specified by testing or statistical analysis.

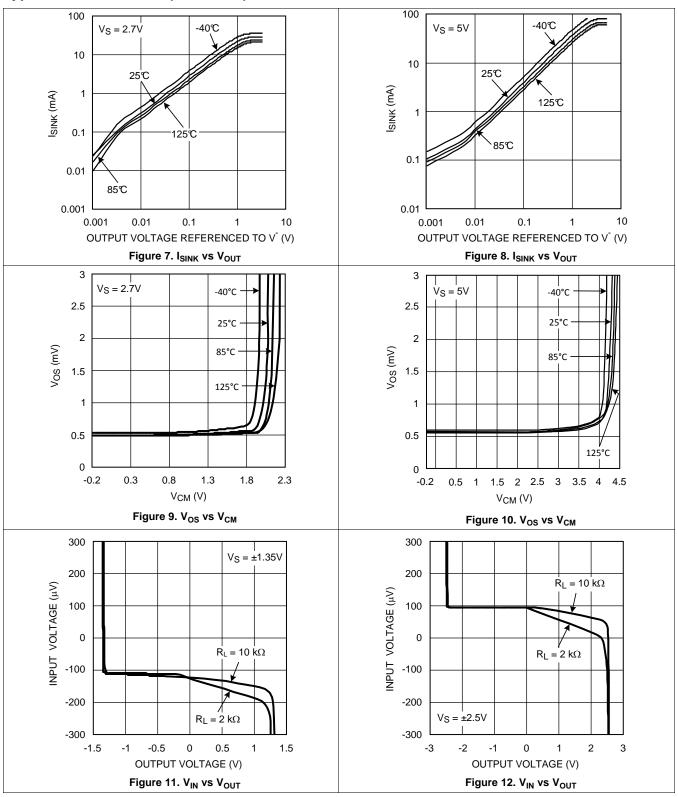
<sup>(3)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and also depends on the application and configuration. The typical values are not tested and are not ensured on shipped production material.



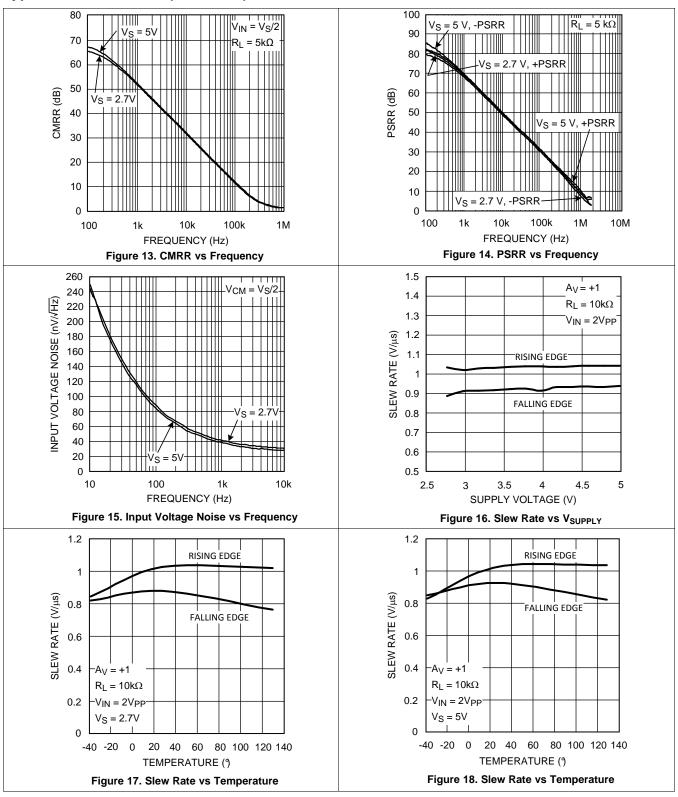
#### 6.9 Typical Characteristics



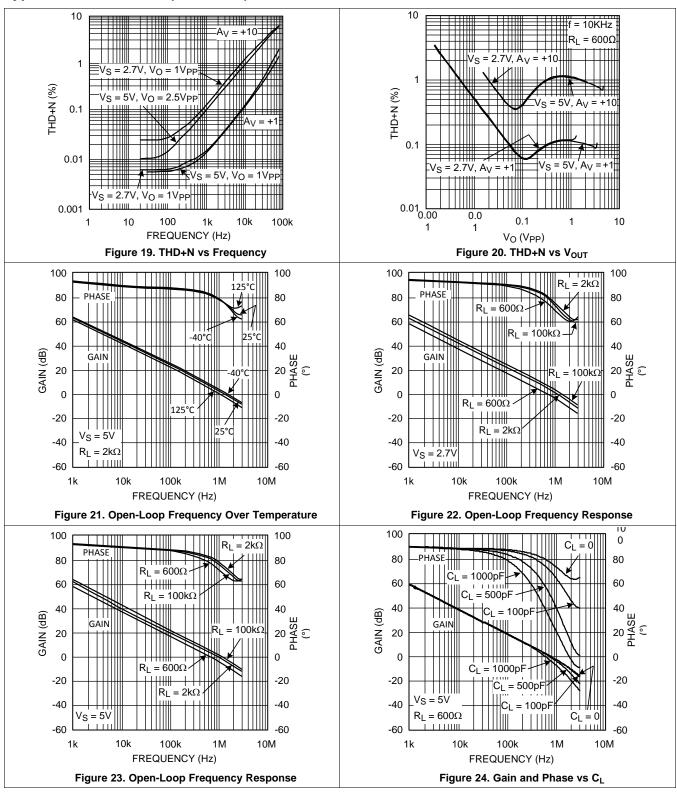




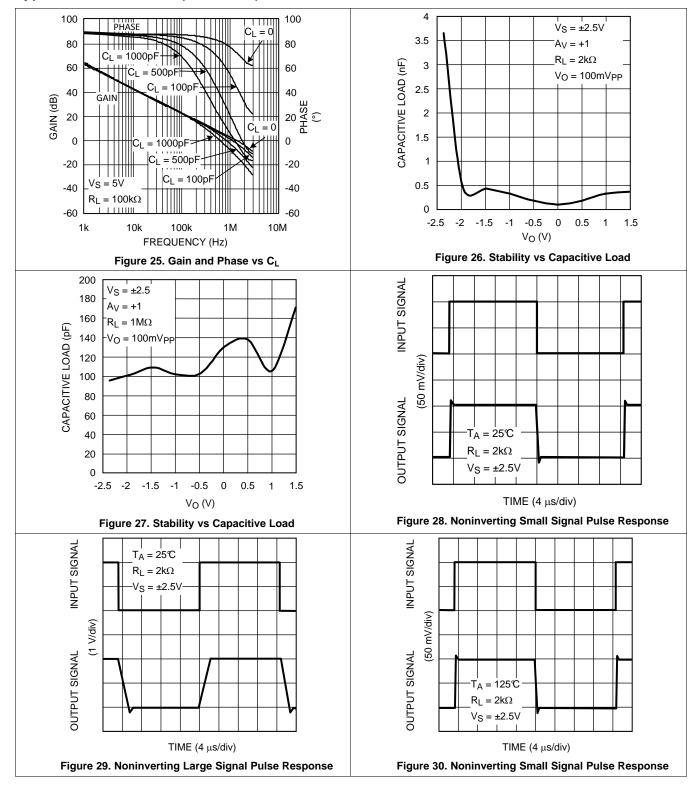




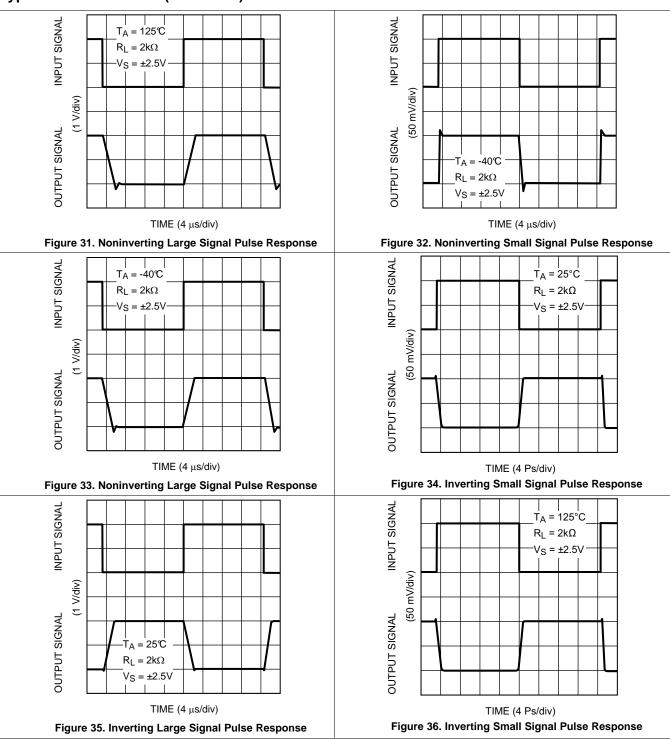




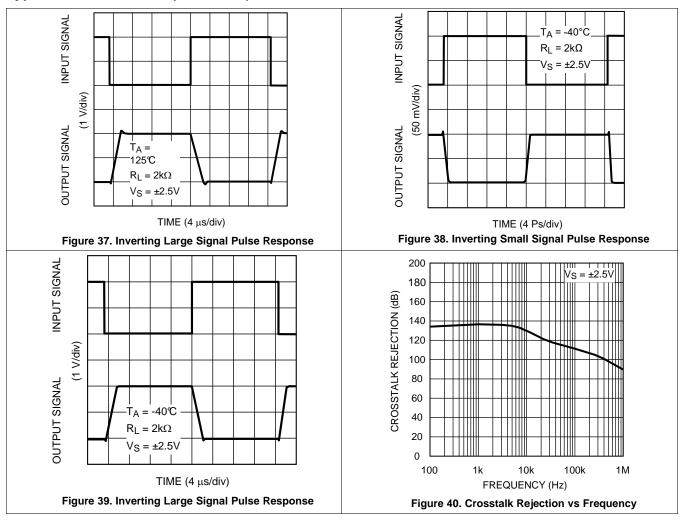












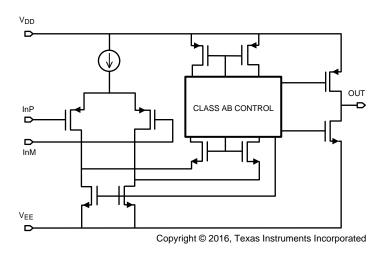


## 7 Detailed Description

#### 7.1 Overview

TI's LMV34x-N family of amplifiers have 1-MHz bandwidth, 1-V/ $\mu$ s slew rate, a rail-to-rail output stage, and consume only 100  $\mu$ A of current per amplifier while active. When in shutdown mode it only consumes 45-pA supply consumption with only 20 fA of input bias current. Lastly, these operational amplifiers provide an input-referred voltage noise 29 nV $\sqrt{Hz}$  (at 10 kHz).

#### 7.2 Functional Block Diagram



#### 7.3 Feature Description

#### 7.3.1 Class AB Turnaround Stage Amplifier

This patented folded cascode stage has a combined class AB amplifier stage, which replaces the conventional folded cascode stage. Therefore, the class AB folded cascode stage runs at a much lower quiescent current compared to conventional-folded cascode stages. This results in significantly smaller offset and noise contributions. The reduced offset and noise contributions in turn reduce the offset voltage level and the voltage noise level at the input of LMV34x-N. Also the lower quiescent current results in a high open-loop gain for the amplifier. The lower quiescent current does not affect the slew rate of the amplifier nor its ability to handle the total current swing coming from the input stage.

The input voltage noise of the device at low frequencies, below 1 kHz, is slightly higher than devices with a BJT input stage; however, the PMOS input stage results in a much lower input bias current and the input voltage noise drops at frequencies above 1 kHz.

#### 7.4 Device Functional Modes

#### 7.4.1 Shutdown Feature

The LMV341-N is capable of being turned off to conserve power and increase battery life in portable devices. Once in shutdown mode the supply current is drastically reduced, 1-µA maximum, and the output is *tri-stated*.

The device is disabled when the shutdown pin voltage is pulled low. The shutdown pin must never be left unconnected. Leaving the pin floating results in an undefined operation mode and the device may oscillate between shutdown and active modes.

The LMV341-N typically turns on 2.8  $\mu$ s after the shutdown voltage is pulled high. The device turns off in less than 400 ns after shutdown voltage is pulled low. Figure 41 and Figure 42 show the turnon and turnoff time of the LMV341-N, respectively. To reduce the effect of the capacitance added to the circuit by the scope probe, in the turnoff time circuit a resistive load of 600  $\Omega$  is added. Figure 43 and Figure 44 show the test circuits used to obtain the two plots.

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## **Device Functional Modes (continued)**

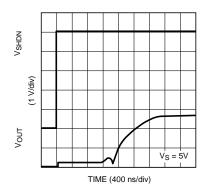


Figure 41. Turnon Time Plot

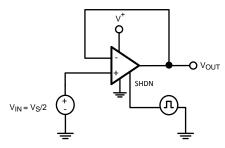


Figure 43. Turnon Time Circuit

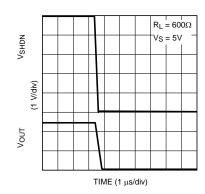


Figure 42. Turnoff Time Plot

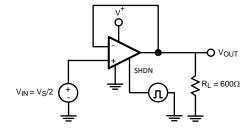


Figure 44. Turnoff Time Circuit

### 7.4.2 Low Input Bias Current

LMV34x-N amplifiers have a PMOS input stage. As a result, they have a much lower input bias current than devices with BJT input stages. This feature makes these devices ideal for sensor circuits. A typical curve of the input bias current of the LMV341-N is shown in Figure 45.

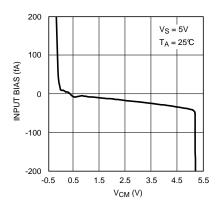


Figure 45. Input Bias Current vs V<sub>CM</sub>



## 8 Application and Implementation

#### NOTE

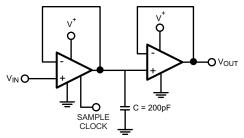
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 8.1 Application Information

The LMV34x-N amplifier family features low voltage, low power, rail-to-rail output as well as a shutdown capability, making it well suited for low voltage portable applications.

## 8.2 Typical Application

#### 8.2.1 Sample and Hold Circuit



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Figure 46. Sample and Hold Circuit

#### 8.2.1.1 Design Requirements

The lower input bias current of the LMV341-N results in a very high input impedance. The output impedance when the device is in shutdown mode is quite high. These high impedances, along with the ability of the shutdown pin to be derived from a separate power source, make LMV341-N a good choice for sample and hold circuits. The sample clock must be connected to the shutdown pin of the amplifier to rapidly turn the device on or off.

#### 8.2.1.2 Detailed Design Procedure

Figure 46 shows the schematic of a simple sample and hold circuit. When the sample clock is high the first amplifier is in normal operation mode and the second amplifier acts as a buffer. The capacitor, which appears as a load on the first amplifier, is charging at this time. The voltage across the capacitor is that of the noninverting input of the first amplifier because it is connected as a voltage-follower. When the sample clock is low the first amplifier is shut off, bringing the output impedance to a high value. The high impedance of this output, along with the very high impedance on the input of the second amplifier, prevents the capacitor from discharging. There is very little voltage droop while the first amplifier is in shutdown mode. The second amplifier, which is still in normal operation mode and is connected as a voltage follower, also provides the voltage sampled on the capacitor at its output.

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## **Typical Application (continued)**

#### 8.2.1.3 Application Curve

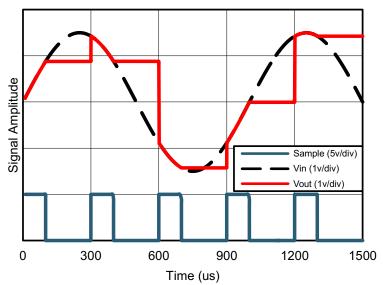


Figure 47. Sample and Hold Circuit Results

## 9 Power Supply Recommendations

For proper operation, the power supplies must be properly decoupled. For decoupling the supply lines, TI recommends that 10-nF capacitors be placed as close as possible to the op amp power supply pins. For single-supply, place a capacitor between  $V^+$  and  $V^-$  supply leads. For dual supplies, place one capacitor between  $V^+$  and ground, and one capacitor between  $V^-$  and ground.



## 10 Layout

#### 10.1 Layout Guidelines

To properly bypass the power supply, several locations on a printed-circuit board need to be considered. A 6.8- $\mu$ F or greater tantalum capacitor must be placed at the point where the power supply for the amplifier is introduced onto the board. Another 0.1- $\mu$ F ceramic capacitor must be placed as close as possible to the power supply pin of the amplifier. If the amplifier is operated in a single power supply, only the V<sup>+</sup> pin needs to be bypassed with a 0.1- $\mu$ F capacitor. If the amplifier is operated in a dual power supply, both V<sup>+</sup> and V<sup>-</sup> pins need to be bypassed.

It is good practice to use a ground plane on a printed-circuit board to provide all components with a low inductive ground connection.

Surface-mount components in 0805 size or smaller are recommended in the LMV341-N application circuits. Designers can take advantage of the VSSOP miniature sizes to condense board layout to save space and reduce stray capacitance.

#### 10.2 Layout Example

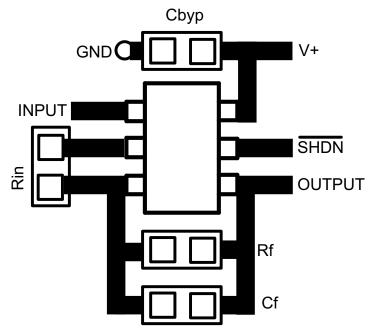


Figure 48. PCB Layout Example



## 11 Device and Documentation Support

#### 11.1 Device Support

#### 11.1.1 Development Support

For development support see the following:

- LMV341-N PSPICE Model (also applicable to the LMV342 and LMV344)
- TINA-TI SPICE-Based Analog Simulation Program
- DIP Adapter Evaluation Module
- TI Universal Operational Amplifier Evaluation Module
- TI Filterpro Software

#### 11.2 Documentation Support

#### 11.2.1 Related Documentation

For related documentation see the following:

AN-31 Op Amp Circuit Collection (SNLA140)

#### 11.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
LMV341-N	Click here	Click here	Click here	Click here	Click here
LMV342-N	Click here	Click here	Click here	Click here	Click here
LMV344-N	Click here	Click here	Click here	Click here	Click here

## 11.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.5 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community T's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.6 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 11.7 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



#### 11.8 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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17-Mar-2017

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LMV341MG/NOPB	ACTIVE	SC70	DCK	6	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A78	Samples
LMV341MGX/NOPB	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A78	Samples
LMV342MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV34 2MA	Samples
LMV342MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV34 2MA	Samples
LMV342MM/NOPB	ACTIVE	VSSOP	DGK	8	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A82A	Samples
LMV342MMX/NOPB	ACTIVE	VSSOP	DGK	8	3500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A82A	Samples
LMV344MA/NOPB	ACTIVE	SOIC	D	14	55	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV344MA	Samples
LMV344MAX/NOPB	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV344MA	Samples
LMV344MT/NOPB	ACTIVE	TSSOP	PW	14	94	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 125	LMV34 4MT	Samples
LMV344MTX/NOPB	ACTIVE	TSSOP	PW	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 125	LMV34 4MT	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.





17-Mar-2017

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF LMV341-N, LMV344-N:

Automotive: LMV341-Q1, LMV344-Q1

NOTE: Qualified Version Definitions:

Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## **PACKAGE MATERIALS INFORMATION**

www.ti.com 15-Apr-2016

## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMV341MG/NOPB	SC70	DCK	6	1000	178.0	8.4	2.25	2.45	1.2	4.0	8.0	Q3
LMV341MGX/NOPB	SC70	DCK	6	3000	178.0	8.4	2.25	2.45	1.2	4.0	8.0	Q3
LMV342MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMV342MM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMV342MMX/NOPB	VSSOP	DGK	8	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMV344MAX/NOPB	SOIC	D	14	2500	330.0	16.4	6.5	9.35	2.3	8.0	16.0	Q1
LMV344MTX/NOPB	TSSOP	PW	14	2500	330.0	12.4	6.95	5.6	1.6	8.0	12.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMV341MG/NOPB	SC70	DCK	6	1000	210.0	185.0	35.0
LMV341MGX/NOPB	SC70	DCK	6	3000	210.0	185.0	35.0
LMV342MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMV342MM/NOPB	VSSOP	DGK	8	1000	210.0	185.0	35.0
LMV342MMX/NOPB	VSSOP	DGK	8	3500	367.0	367.0	35.0
LMV344MAX/NOPB	SOIC	D	14	2500	367.0	367.0	35.0
LMV344MTX/NOPB	TSSOP	PW	14	2500	367.0	367.0	35.0

# DCK (R-PDSO-G6)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



# DCK (R-PDSO-G6)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



## D (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



PW (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
  - Sody length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



## D (R-PDSO-G8)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



# DGK (S-PDSO-G8)

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



# DGK (S-PDSO-G8)

## PLASTIC SMALL OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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Unless TI has explicitly designated an individual product as meeting the requirements of a particular industry standard (e.g., ISO/TS 16949 and ISO 26262), TI is not responsible for any failure to meet such industry standard requirements.

Where TI specifically promotes products as facilitating functional safety or as compliant with industry functional safety standards, such products are intended to help enable customers to design and create their own applications that meet applicable functional safety standards and requirements. Using products in an application does not by itself establish any safety features in the application. Designers must ensure compliance with safety-related requirements and standards applicable to their applications. Designer may not use any TI products in life-critical medical equipment unless authorized officers of the parties have executed a special contract specifically governing such use. Life-critical medical equipment is medical equipment where failure of such equipment would cause serious bodily injury or death (e.g., life support, pacemakers, defibrillators, heart pumps, neurostimulators, and implantables). Such equipment includes, without limitation, all medical devices identified by the U.S. Food and Drug Administration as Class III devices and equivalent classifications outside the U.S.

TI may expressly designate certain products as completing a particular qualification (e.g., Q100, Military Grade, or Enhanced Product). Designers agree that it has the necessary expertise to select the product with the appropriate qualification designation for their applications and that proper product selection is at Designers' own risk. Designers are solely responsible for compliance with all legal and regulatory requirements in connection with such selection.

Designer will fully indemnify TI and its representatives against any damages, costs, losses, and/or liabilities arising out of Designer's non-compliance with the terms and provisions of this Notice.